



PROBE TIP AND METHOD OF MANUFACTURING PROBE TIPS BY PEEL-OFF

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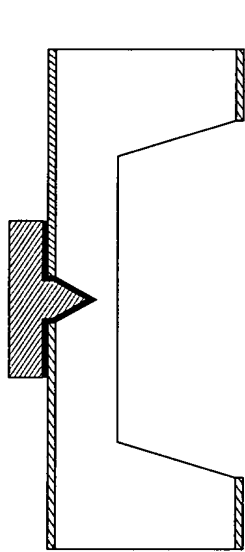


FIG. 1D
(PRIOR ART)

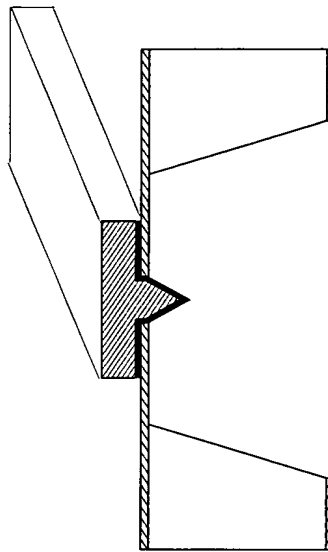


FIG. 1E
(PRIOR ART)

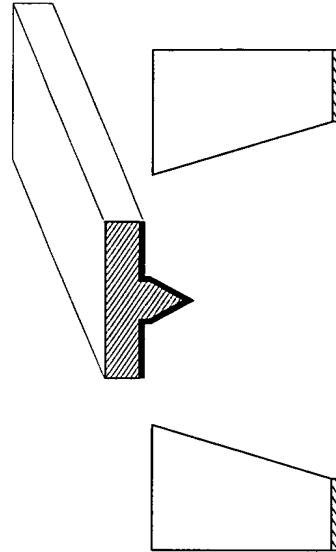


FIG. 1F
(PRIOR ART)

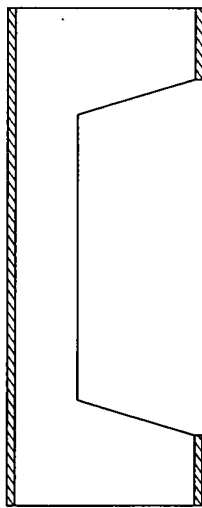


FIG. 1A
(PRIOR ART)

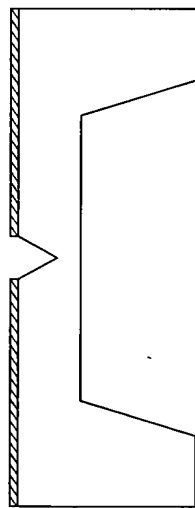


FIG. 1B
(PRIOR ART)

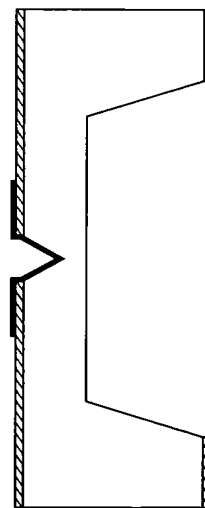
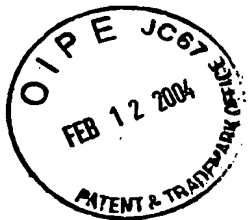


FIG. 1C
(PRIOR ART)



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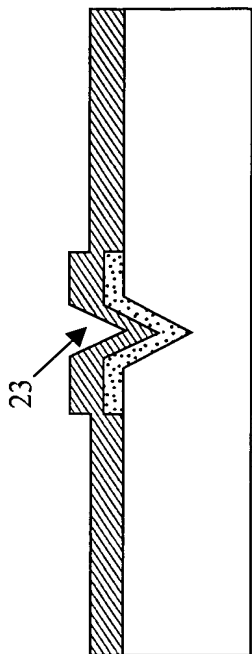


FIG. 2B
(PRIOR ART)

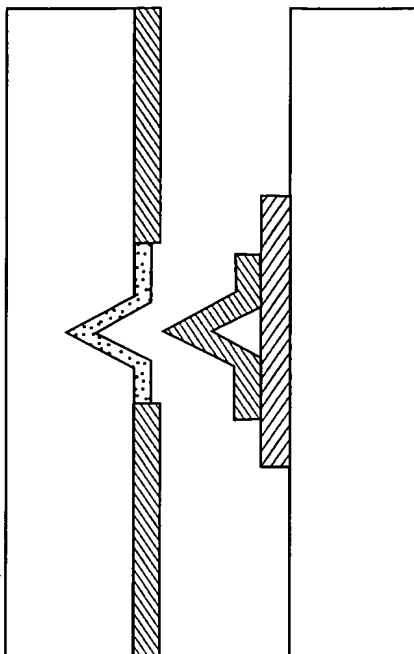


FIG. 2D
(PRIOR ART)

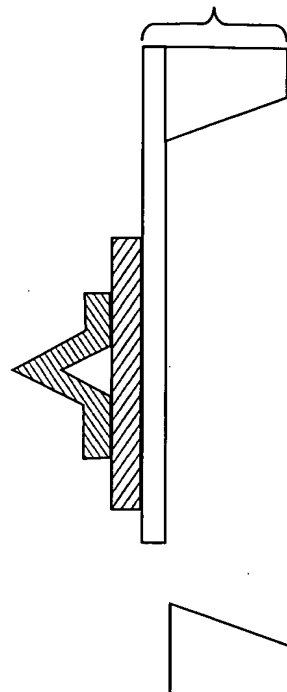


FIG. 2E
(PRIOR ART)

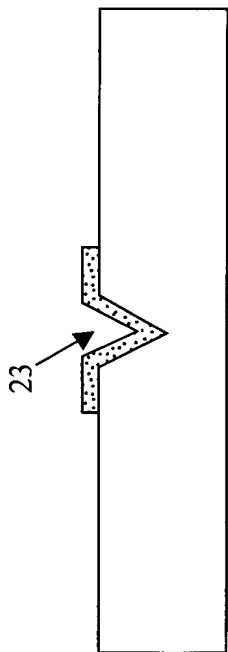


FIG. 2A
(PRIOR ART)

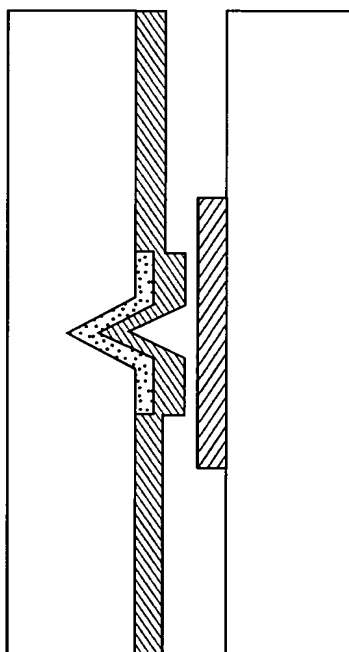
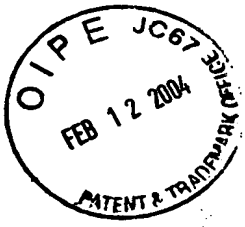


FIG. 2C
(PRIOR ART)



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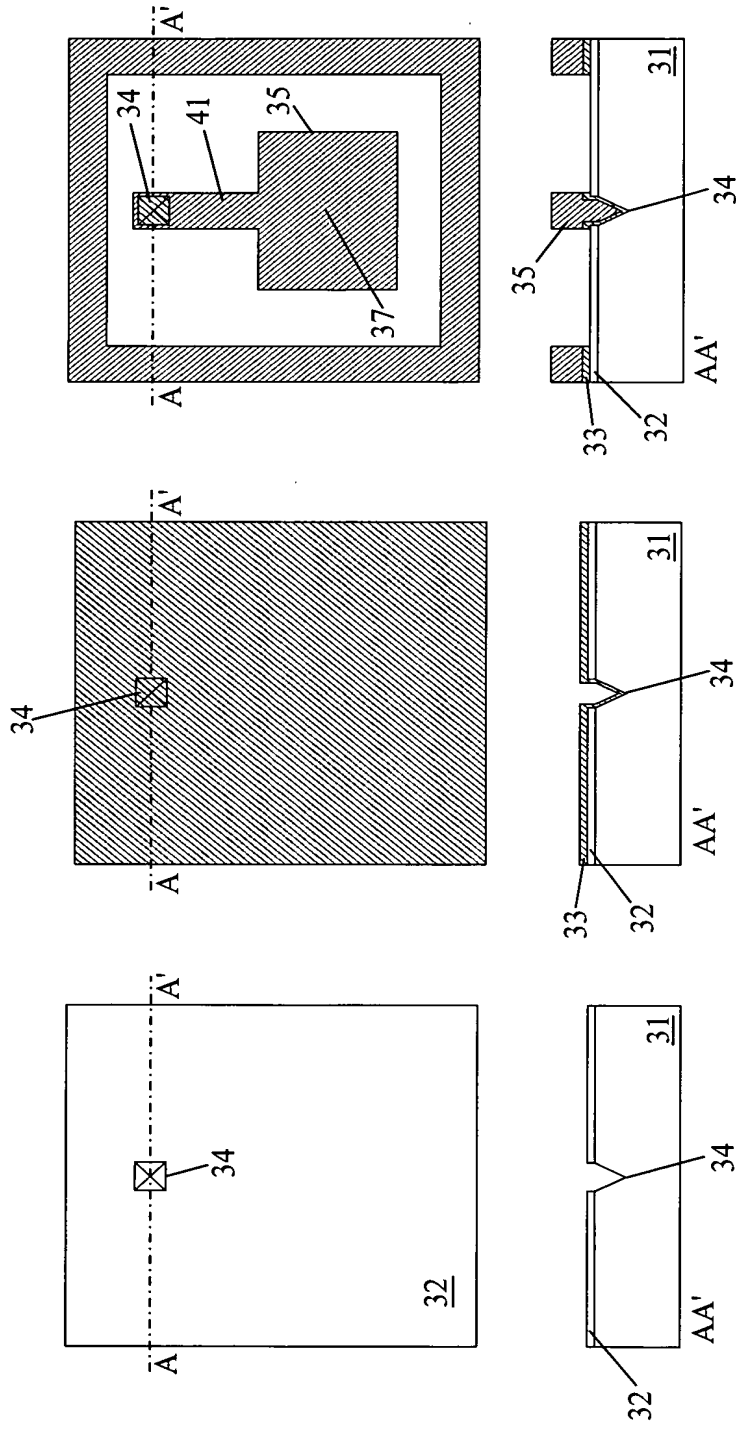


FIG. 3C

FIG. 3B

FIG. 3A



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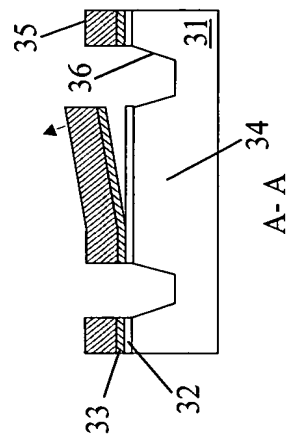
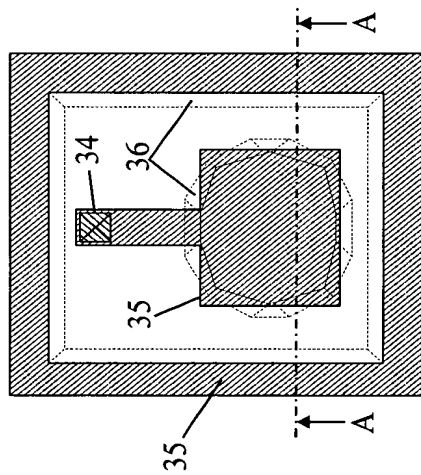


FIG. 3E

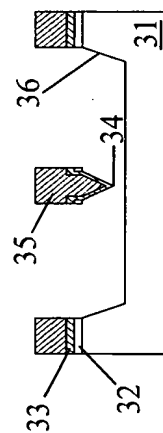


FIG. 3D



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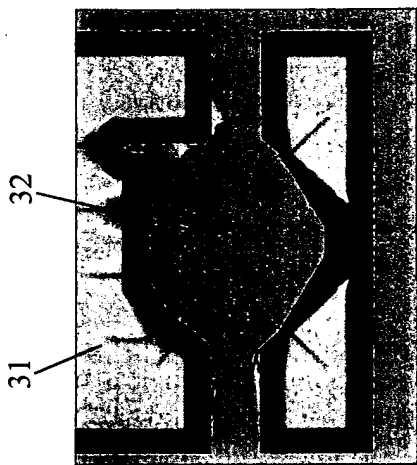


FIG. 4C

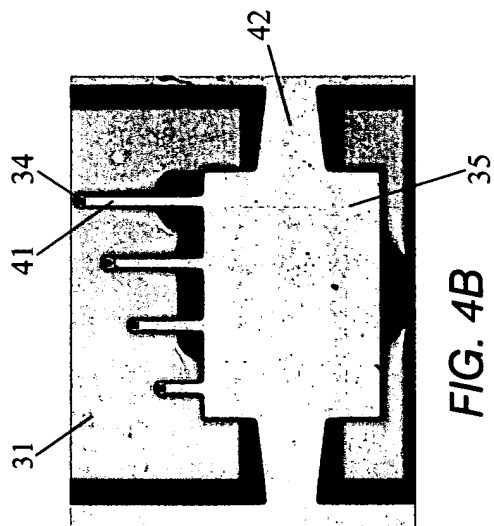


FIG. 4B

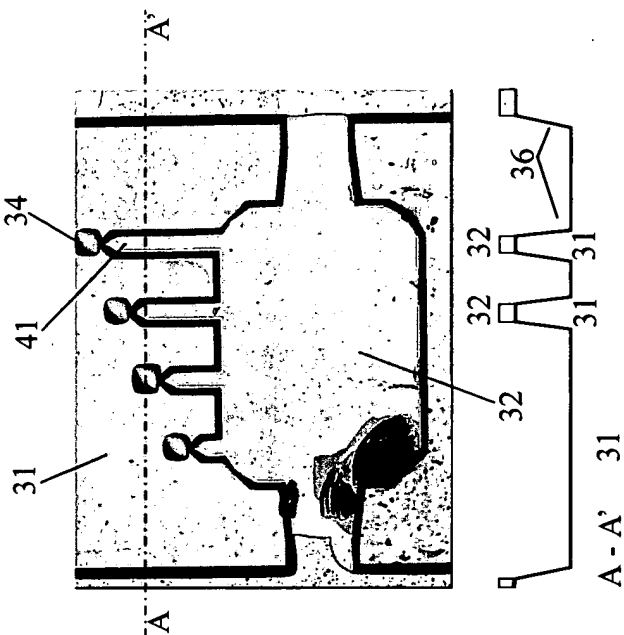


FIG. 4E

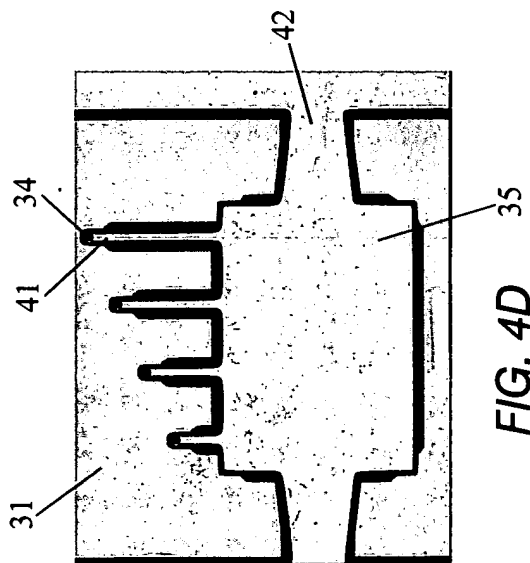


FIG. 4D

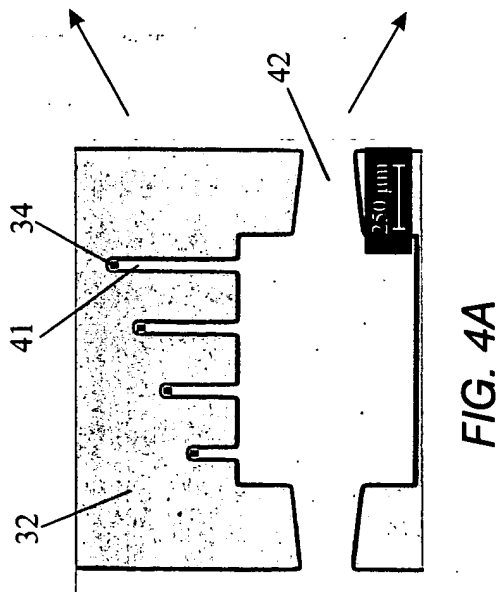


FIG. 4A



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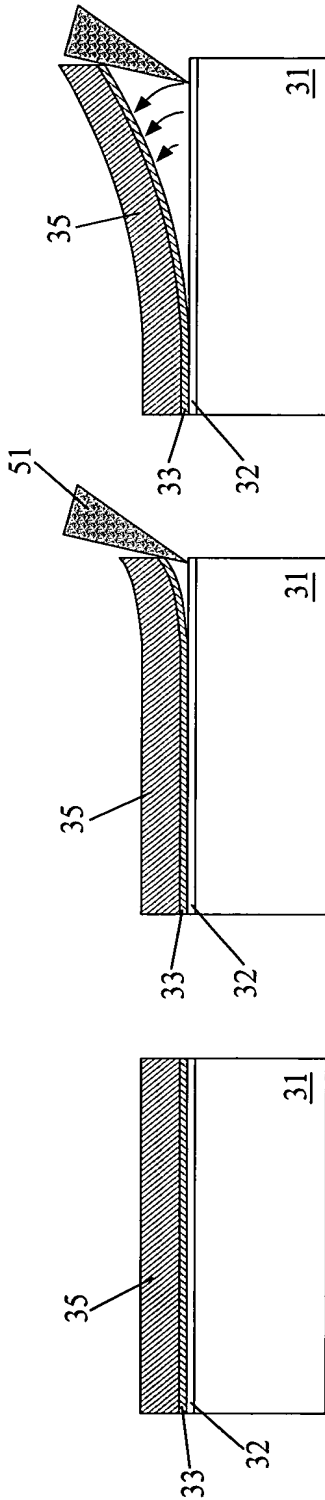


FIG. 5A

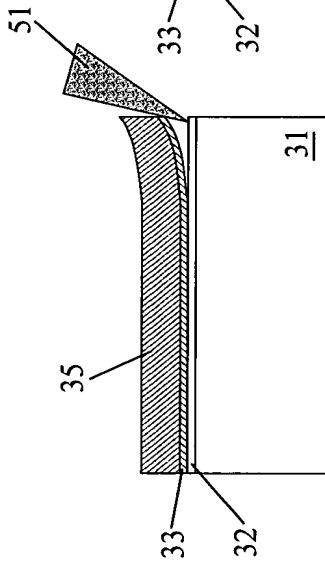


FIG. 5B

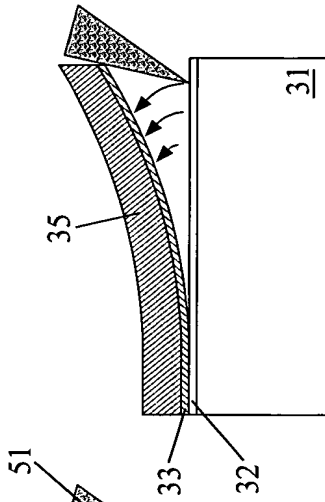


FIG. 5C

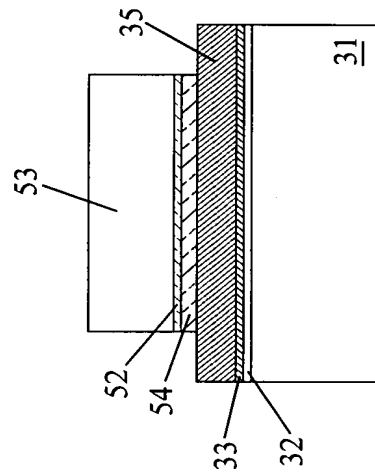


FIG. 5D

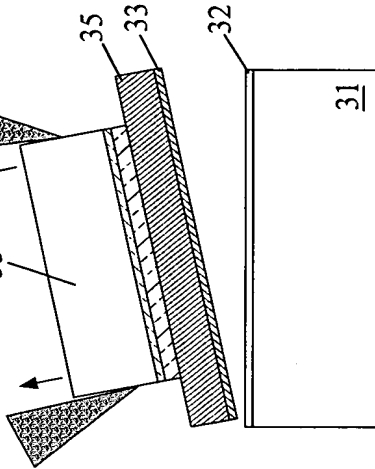


FIG. 5E

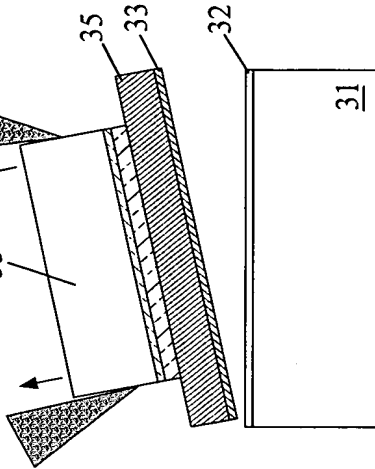


FIG. 5F

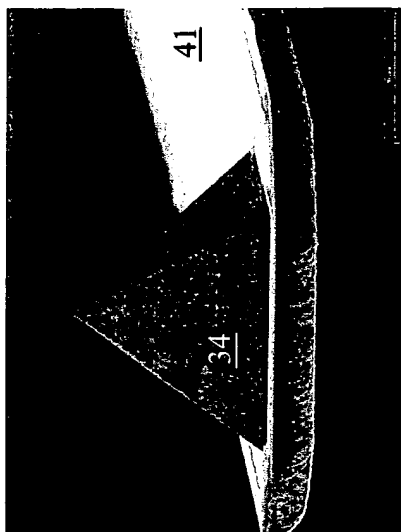


FIG. 6B

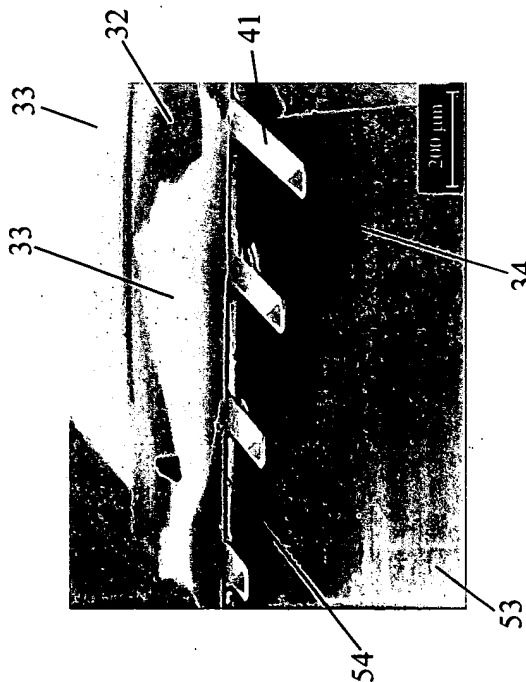


FIG. 6A

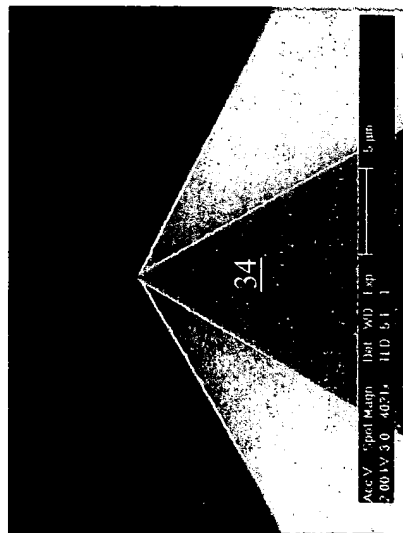


FIG. 6C

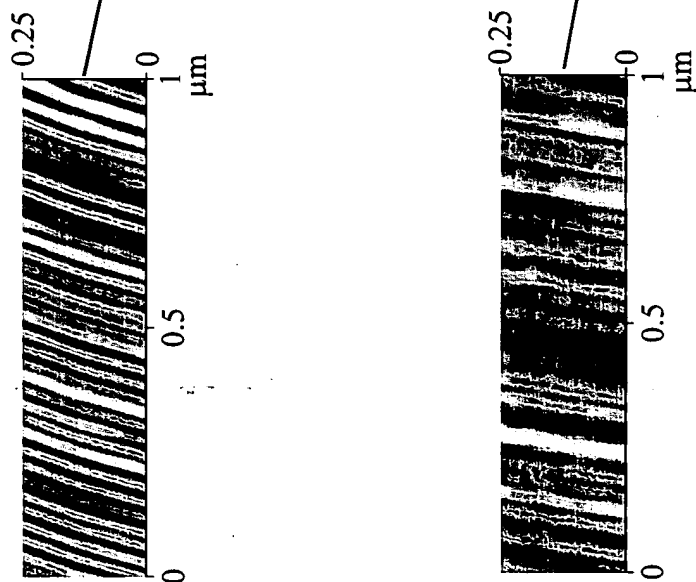
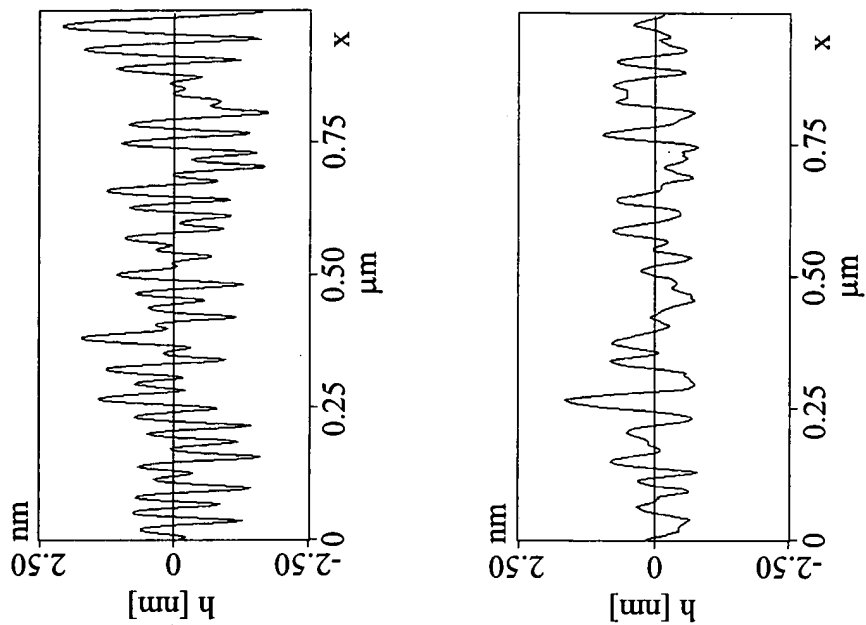
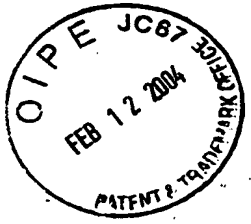


FIG. 7A

FIG. 7B



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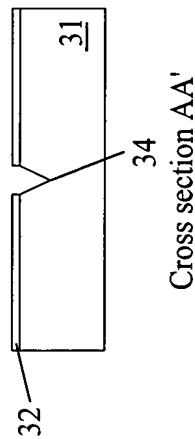
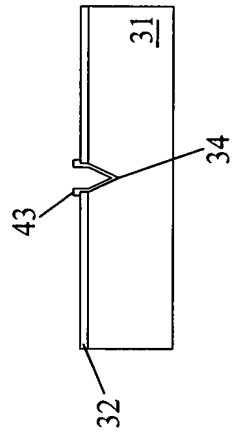
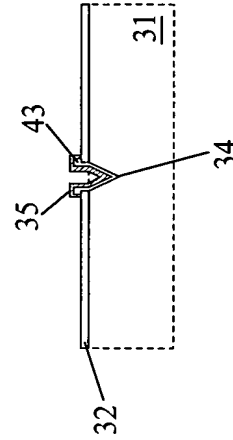
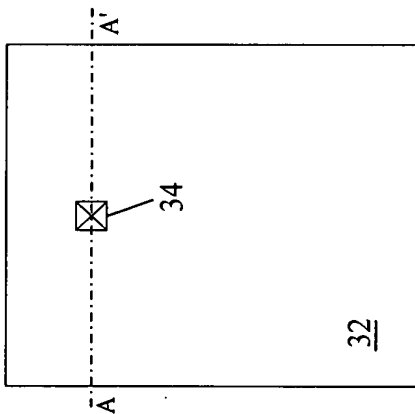
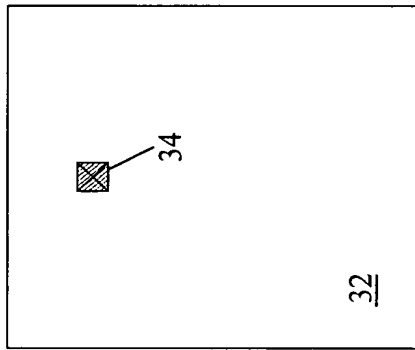
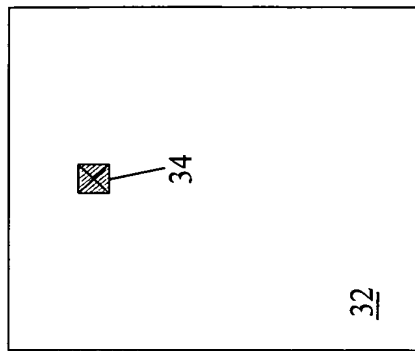
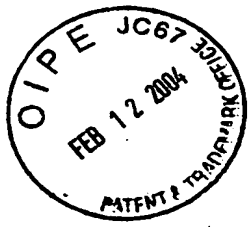


FIG. 8A

FIG. 8B

FIG. 8C



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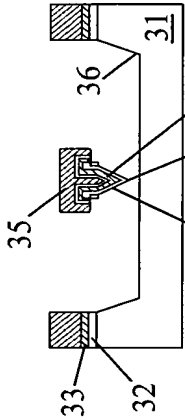
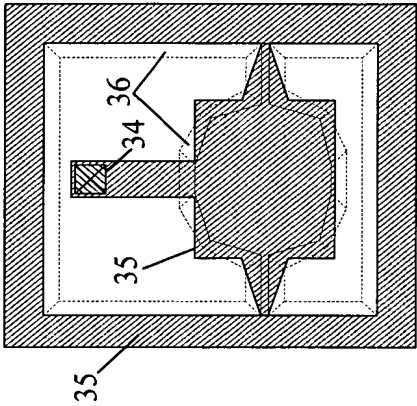


FIG. 8E

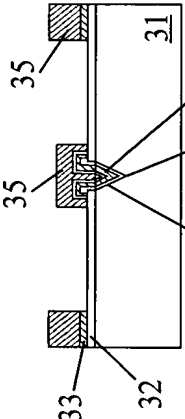
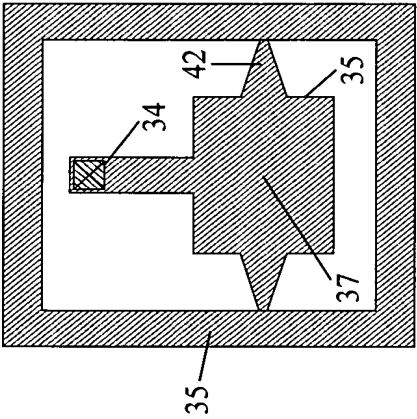


FIG. 8D



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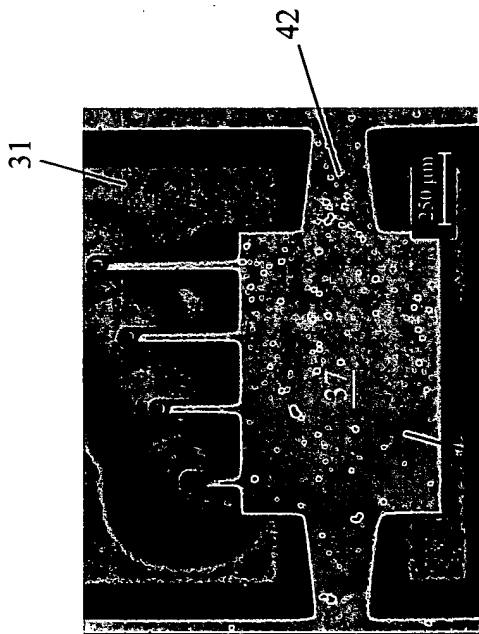


FIG. 9A

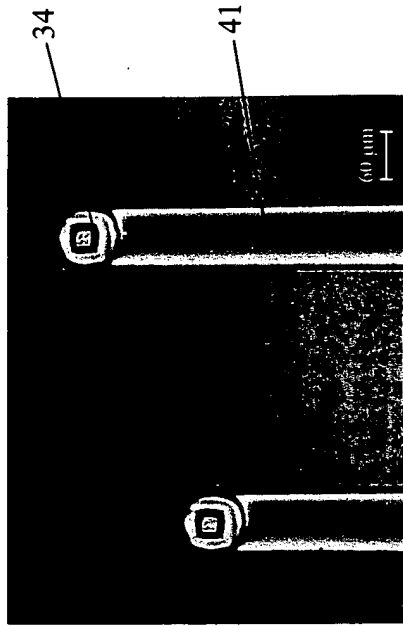


FIG. 9B



FIG. 9C

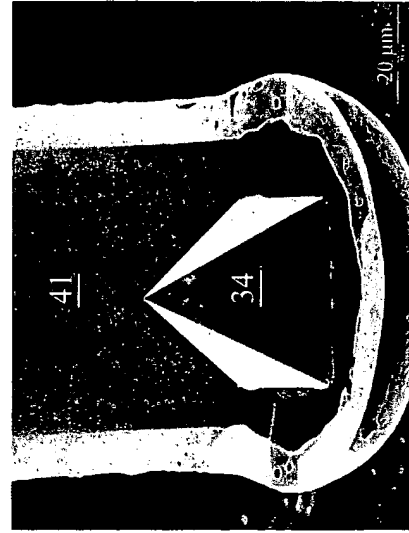


FIG. 9D

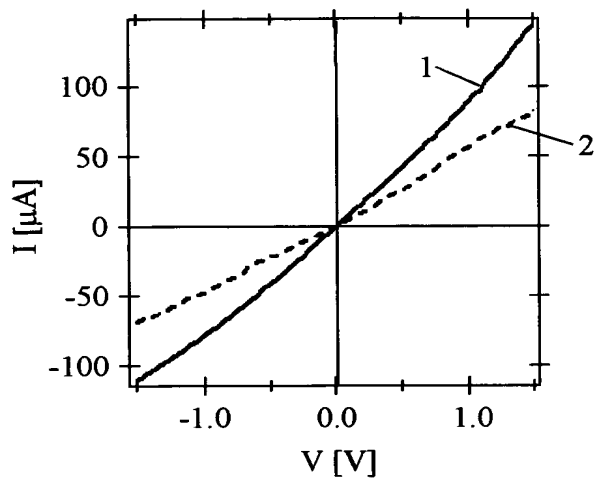
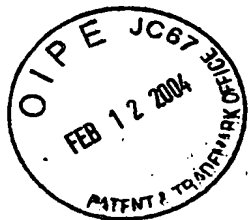


FIG. 10A

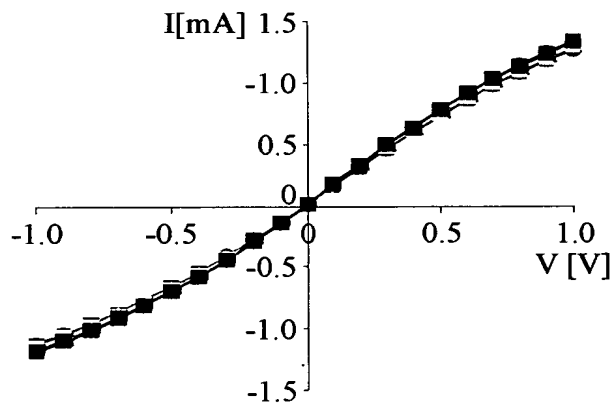


FIG. 10B

FIG. 11A

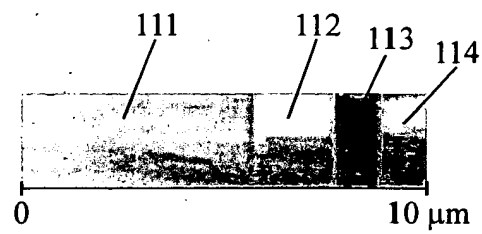


FIG. 11B

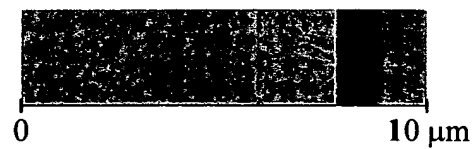


FIG. 11C

